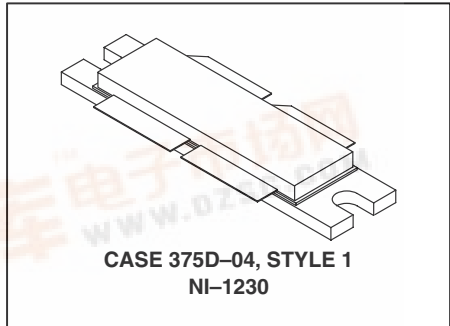


The RF Sub-Micron MOSFET Line
RF Power Field Effect Transistor
N-Channel Enhancement-Mode Lateral MOSFET



**2170 MHz, 180 W AVG.,
 2 x W-CDMA, 28 V
 LATERAL N-CHANNEL
 RF POWER MOSFET**



Designed for W-CDMA base station applications with frequencies from 2110 to 2170 MHz. Suitable for TDMA, CDMA and multicarrier amplifier applications. To be used in Class AB for PCN-PCS/cellular radio and WLL applications.

- Typical 2-carrier W-CDMA Performance for $V_{DD} = 28$ Volts, $I_{DQ} = 2 \times 800$ mA, $f_1 = 2135$ MHz, $f_2 = 2145$ MHz, Channel Bandwidth = 3.84 MHz, Adjacent Channels Measured over 3.84 MHz BW @ $f_1 - 5$ MHz and $f_2 + 5$ MHz. Distortion Products Measured over a 3.84 MHz BW @ $f_1 - 10$ MHz and $f_2 + 10$ MHz, Each Carrier Peak/Avg. = 8.5 dB @ 0.01% Probability on CCDF.
 Output Power — 38 Watts Avg.
 Power Gain — 14 dB
 Efficiency — 25.5%
 IM3 — 37.5 dBc
 ACPR — -41 dBc
- Internally Matched, Controlled Q, for Ease of Use
- High Gain, High Efficiency and High Linearity
- Integrated ESD Protection
- Designed for Maximum Gain and Insertion Phase Flatness
- Capable of Handling 10:1 VSWR, @ 28 Vdc, 2140 MHz, 180 Watts CW Output Power
- Excellent Thermal Stability
- Characterized with Series Equivalent Large-Signal Impedance Parameters
- Qualified Up to a Maximum of 32 V_{DD} Operation

MAXIMUM RATINGS

| Rating | Symbol | Value | Unit |
|--|-----------|--------------|------------------------------------|
| Drain-Source Voltage | V_{DSS} | 65 | Vdc |
| Gate-Source Voltage | V_{GS} | -0.5, +15 | Vdc |
| Total Device Dissipation @ $T_C = 25^\circ\text{C}$ Derate above 25°C | P_D | 437.5 2.5 | Watts $\text{W}/^\circ\text{C}$ |
| Storage Temperature Range | T_{stg} | -65 to +150 | $^\circ\text{C}$ |
| Operating Junction Temperature | T_J | 200 | $^\circ\text{C}$ |

NOTE – **CAUTION** – MOS devices are susceptible to damage from electrostatic charge. Reasonable precautions in handling and packaging MOS devices should be observed.

THERMAL CHARACTERISTICS

| Characteristic | Symbol | Max | Unit |
|---|-----------------|--------------|------|
| Thermal Resistance, Junction to Case Case Temperature 80°C, 180 W CW Case Temperature 80°C, 38 W CW | $R_{\theta JC}$ | 0.40 0.40 | °C/W |

ELECTRICAL CHARACTERISTICS ($T_C = 25^\circ\text{C}$ unless otherwise noted)

| Characteristic | Symbol | Min | Typ | Max | Unit |
|----------------|--------|-----|-----|-----|------|
|----------------|--------|-----|-----|-----|------|

OFF CHARACTERISTICS (1)

| | | | | | |
|---|-----------|---|---|----|---------------|
| Zero Gate Voltage Drain Leakage Current ($V_{DS} = 65\text{ Vdc}$, $V_{GS} = 0\text{ Vdc}$) | I_{DSS} | — | — | 10 | μA |
| Zero Gate Voltage Drain Leakage Current ($V_{DS} = 28\text{ Vdc}$, $V_{GS} = 0$) | I_{DSS} | — | — | 1 | μA |
| Gate–Source Leakage Current ($V_{GS} = 5\text{ Vdc}$, $V_{DS} = 0\text{ Vdc}$) | I_{GSS} | — | — | 1 | μA |

ON CHARACTERISTICS (1)

| | | | | | |
|---|--------------|-----|------|-----|-----|
| Gate Threshold Voltage ($V_{DS} = 10\text{ Vdc}$, $I_D = 200\ \mu\text{A}$) | $V_{GS(th)}$ | 2.5 | 2.8 | 3.5 | Vdc |
| Gate Quiescent Voltage ($V_{DS} = 28\text{ Vdc}$, $I_D = 800\ \text{mA}$) | $V_{GS(Q)}$ | — | 3.6 | — | Vdc |
| Drain–Source On–Voltage ($V_{GS} = 10\text{ Vdc}$, $I_D = 2\text{ A}$) | $V_{DS(on)}$ | — | 0.26 | 0.3 | Vdc |
| Forward Transconductance ($V_{DS} = 10\text{ Vdc}$, $I_D = 2\text{ A}$) | g_{fs} | — | 5 | — | S |

DYNAMIC CHARACTERISTICS (1)

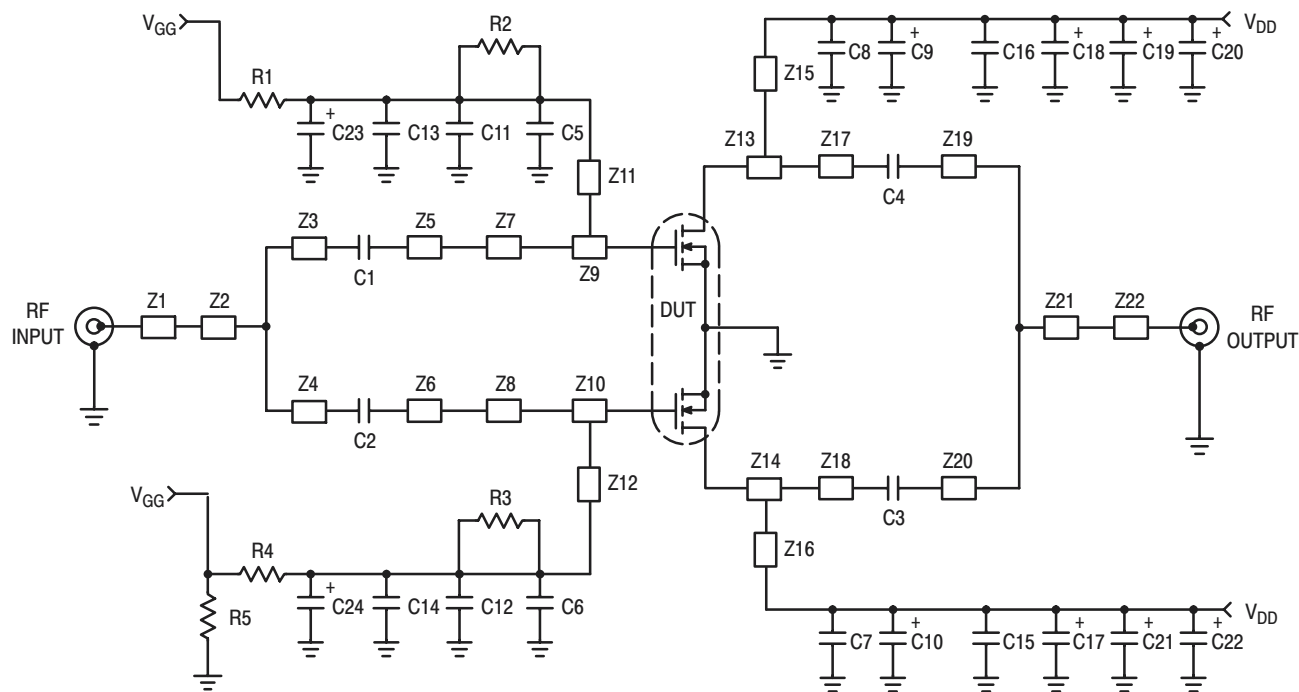
| | | | | | |
|--|-----------|---|-----|---|----|
| Reverse Transfer Capacitance ($V_{DS} = 28\text{ Vdc} \pm 30\text{ mV(rms)}$ ac @ 1 MHz, $V_{GS} = 0\text{ Vdc}$) | C_{rss} | — | 1.7 | — | pF |
|--|-----------|---|-----|---|----|

FUNCTIONAL TESTS (In Motorola Test Fixture, 50 ohm system) (2) 2–carrier W–CDMA, 3.84 MHz Channel Bandwidth Carriers, ACPR and IM3 measured in 3.84 MHz Bandwidth. Peak/Avg. = 8.5 dB @ 0.01% Probability on CCDF.

| | | | | | |
|--|----------|------|-------|-----|-----|
| Common–Source Amplifier Power Gain ($V_{DD} = 28\text{ Vdc}$, $P_{out} = 38\text{ W Avg.}$, $I_{DQ} = 2 \times 800\text{ mA}$, $f_1 = 2112.5\text{ MHz}$, $f_2 = 2122.5\text{ MHz}$ and $f_1 = 2157.5\text{ MHz}$, $f_2 = 2167.5\text{ MHz}$) | G_{ps} | 12.5 | 14 | — | dB |
| Drain Efficiency ($V_{DD} = 28\text{ Vdc}$, $P_{out} = 38\text{ W Avg.}$, $I_{DQ} = 2 \times 800\text{ mA}$, $f_1 = 2112.5\text{ MHz}$, $f_2 = 2122.5\text{ MHz}$ and $f_1 = 2157.5\text{ MHz}$, $f_2 = 2167.5\text{ MHz}$) | η | 23 | 25.5 | — | % |
| Third Order Intermodulation Distortion ($V_{DD} = 28\text{ Vdc}$, $P_{out} = 38\text{ W Avg.}$, $I_{DQ} = 2 \times 800\text{ mA}$, $f_1 = 2112.5\text{ MHz}$, $f_2 = 2122.5\text{ MHz}$ and $f_1 = 2157.5\text{ MHz}$, $f_2 = 2167.5\text{ MHz}$; IM3 measured over 3.84 MHz BW @ $f_1 - 10\text{ MHz}$ and $f_2 + 10\text{ MHz}$ referenced to carrier channel power.) | IM3 | — | –37.5 | –35 | dBc |
| Adjacent Channel Power Ratio ($V_{DD} = 28\text{ Vdc}$, $P_{out} = 38\text{ W Avg.}$, $I_{DQ} = 2 \times 800\text{ mA}$, $f_1 = 2112.5\text{ MHz}$, $f_2 = 2122.5\text{ MHz}$ and $f_1 = 2157.5\text{ MHz}$, $f_2 = 2167.5\text{ MHz}$; ACPR measured over 3.84 MHz BW @ $f_1 - 5\text{ MHz}$ and $f_2 + 5\text{ MHz}$.) | ACPR | — | –41 | –38 | dBc |
| Input Return Loss ($V_{DD} = 28\text{ Vdc}$, $P_{out} = 38\text{ W Avg.}$, $I_{DQ} = 2 \times 800\text{ mA}$, $f_1 = 2112.5\text{ MHz}$, $f_2 = 2122.5\text{ MHz}$ and $f_1 = 2157.5\text{ MHz}$, $f_2 = 2167.5\text{ MHz}$) | IRL | — | –14 | –9 | dB |

(1) Each side of device measured separately. Part is internally matched both on input and output.

(2) Measurements made with device in push–pull configuration.



- | | | | |
|---------|----------------------------|----------|--|
| Z1, Z22 | 1.000" x 0.066" Microstrip | Z9, Z10 | 0.256" x 0.650" Microstrip |
| Z2, Z21 | 0.760" x 0.113" Microstrip | Z11, Z12 | 1.030" x 0.035" Microstrip |
| Z3, Z20 | 0.068" x 0.066" Microstrip | Z13, Z14 | 0.500" x 0.650" Microstrip |
| Z4, Z19 | 1.672" x 0.066" Microstrip | Z15, Z16 | 0.550" x 0.058" Microstrip |
| Z5, Z6 | 0.318" x 0.066" Microstrip | Z17, Z18 | 0.353" x 0.066" Microstrip |
| Z7, Z8 | 0.284" x 0.180" Microstrip | PCB | Taconic RF-35, 0.76 mm, $\epsilon_r = 3.5$ |

Figure 1. MRF5P21180 Test Circuit Schematic

Table 1. MRF5P21180 Test Circuit Component Designations and Values

| Part | Description | Value, P/N or DWG | Manufacturer |
|------------------------------|--------------------------------------|------------------------------|--------------|
| C1, C2, C3, C4 | 30 pF Chip Capacitors | 100B300JCA500X | ATC |
| C5, C6, C7, C8 | 5.6 pF Chip Capacitors | 100B5R6JCA500X | ATC |
| C9, C10 | 10 μ F Tantalum Capacitors | T495X106K035AS4394 | Kemet |
| C11, C12 | 1000 pF Chip Capacitors | 100B102JCA500X | ATC |
| C13, C14, C15, C16 | 0.1 μ F Chip Capacitors | CDR33BX104AKWS | Kemet |
| C17, C18, C19, C20, C21, C22 | 22 μ F Tantalum Capacitors | T491X226K035AS4394 | Kemet |
| C23, C24 | 1.0 μ F Tantalum Capacitors | T491C105M050 | Kemet |
| R1, R2, R3, R4 | 10 Ω , 1/8 W Chip Resistors | | |
| R5 | 1.0 k Ω , 1/8 W Chip Resistor | | |
| WB1, WB2, WB3, WB4 | Wear Blocks | 5 x 180 x 500 mil Brass Shim | Motorola |

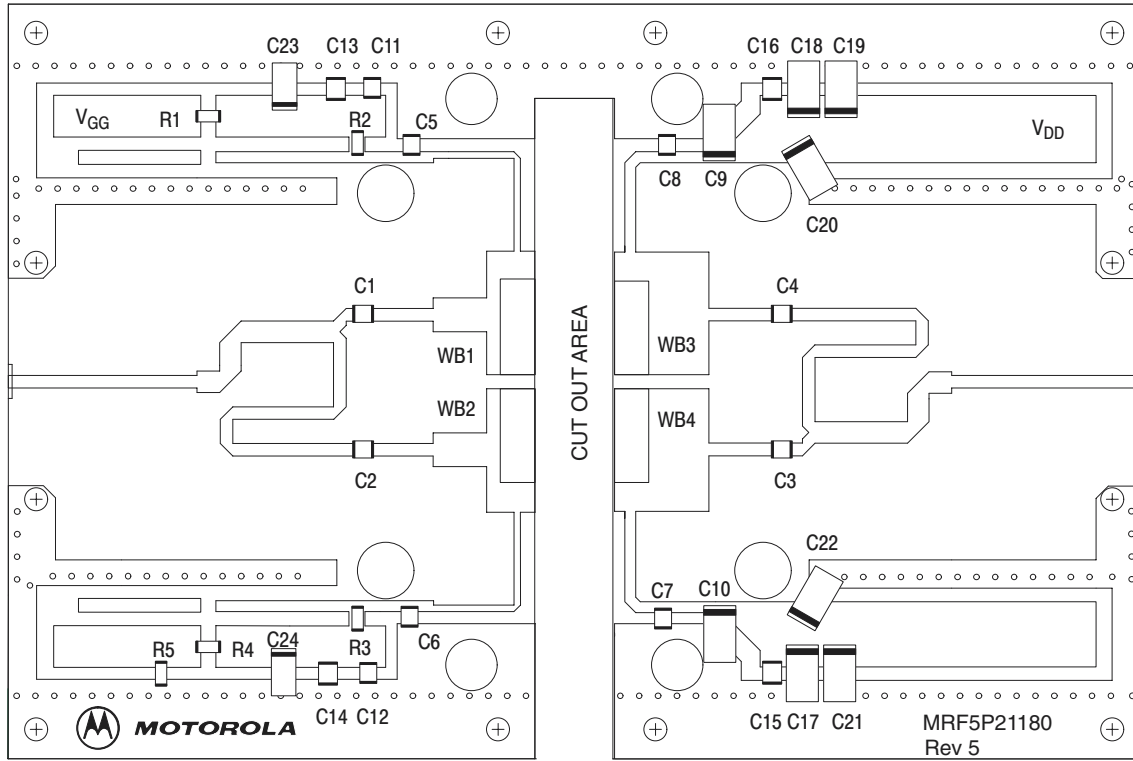


Figure 2. MRF5P21180 Test Circuit Component Layout

TYPICAL CHARACTERISTICS

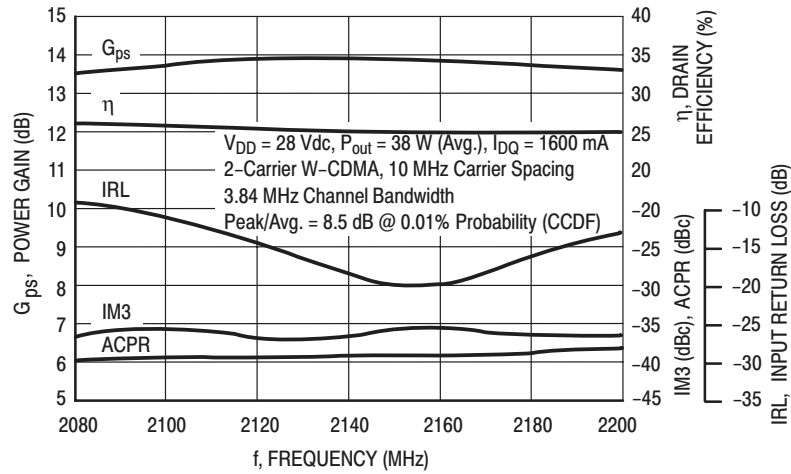


Figure 3. 2-Carrier W-CDMA Broadband Performance

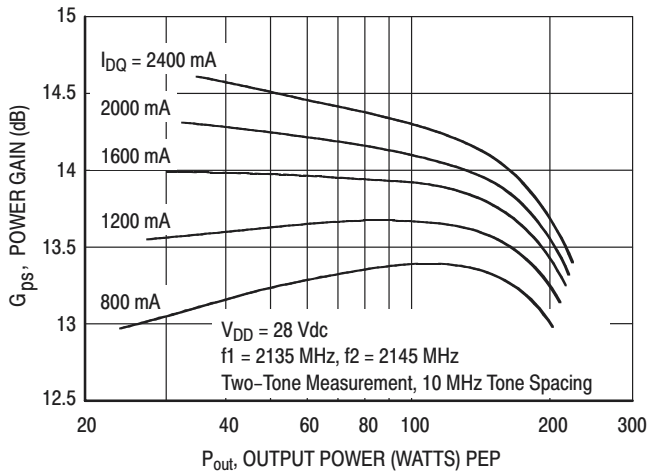


Figure 4. Two-Tone Power Gain versus Output Power

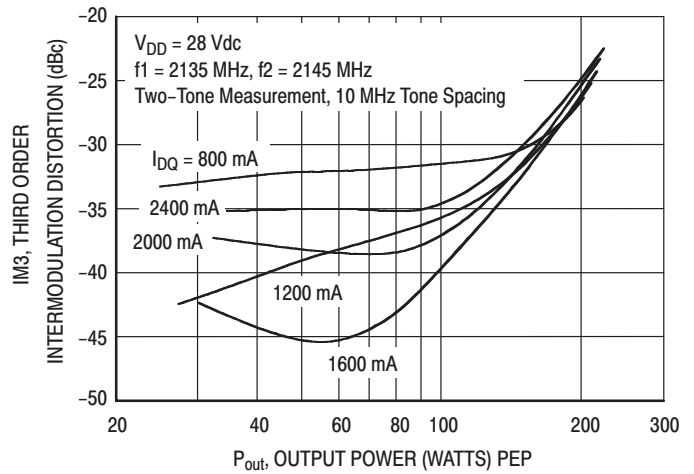


Figure 5. Third Order Intermodulation Distortion versus Output Power

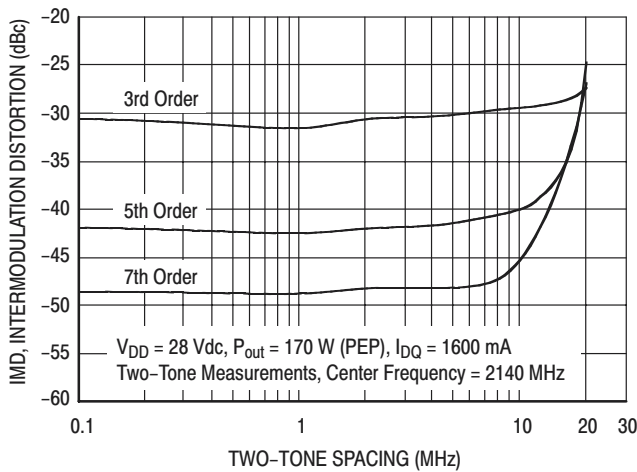


Figure 6. Intermodulation Distortion Products versus Tone Spacing

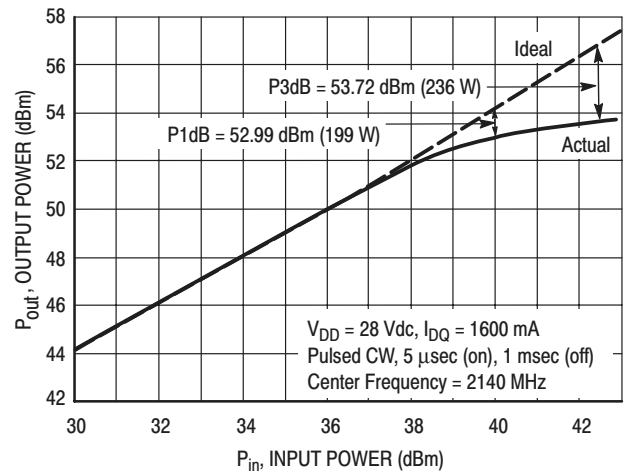


Figure 7. Pulse CW Output Power versus Input Power

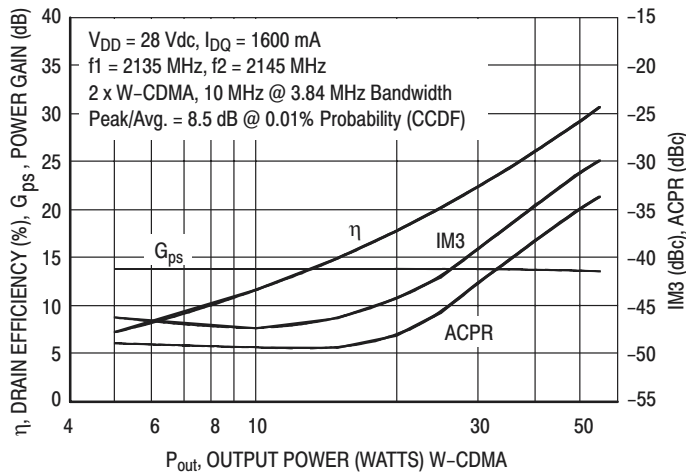


Figure 8. 2-Carrier W-CDMA ACPR, IM3, Power Gain and Drain Efficiency versus Output Power

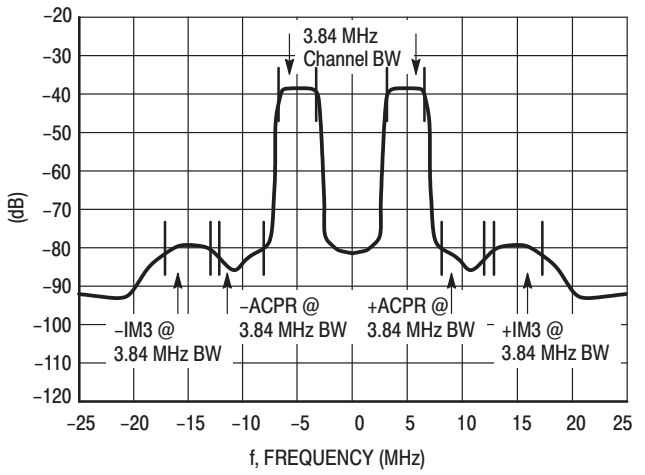


Figure 9. 2-Carrier W-CDMA Spectrum

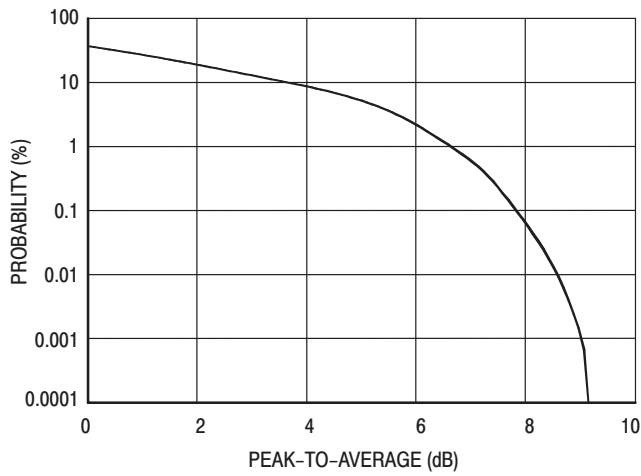
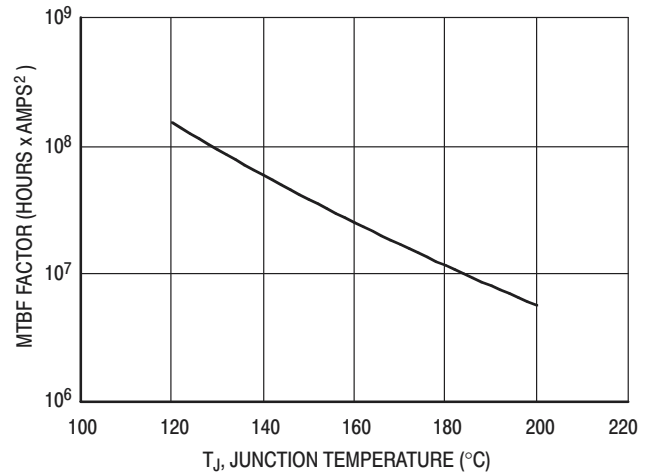
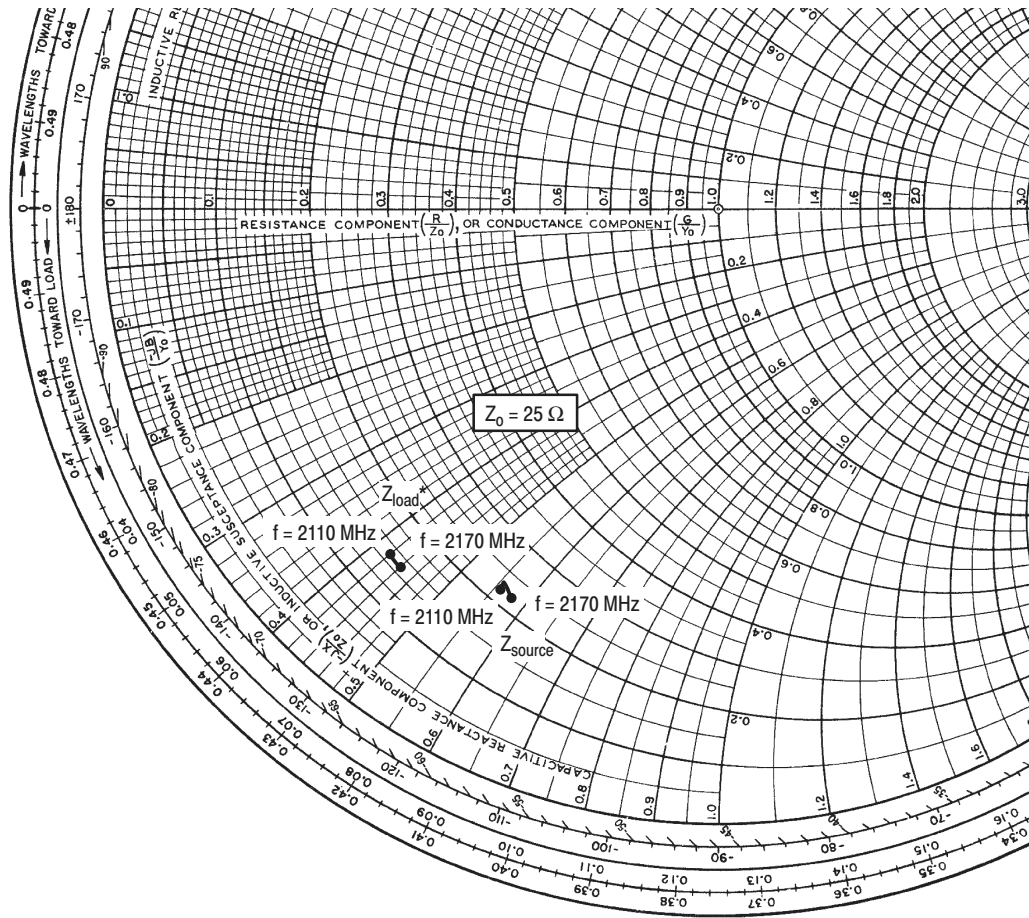


Figure 10. CCDF W-CDMA 3GPP, Test Model 1, 64 DPCH, 67% Clipping, Single Carrier Test Signal



This above graph displays calculated MTBF in hours x ampere² drain current. Life tests at elevated temperatures have correlated to better than $\pm 10\%$ of the theoretical prediction for metal failure. Divide MTBF factor by I_D^2 for MTBF in a particular application.

Figure 11. MTBF Factor versus Junction Temperature



$V_{DD} = 28 \text{ V}$, $I_{DQ} = 2 \times 800 \text{ mA}$, $P_{out} = 38 \text{ W Avg.}$

| f MHz | Z_{source} Ω | Z_{load} Ω |
|----------|--------------------------|------------------------|
| 2110 | $5.39 - j13.89$ | $3.69 - j10.51$ |
| 2140 | $5.66 - j13.99$ | $3.81 - j10.66$ |
| 2170 | $5.53 - j14.51$ | $3.79 - j11.05$ |

Z_{source} = Test circuit impedance as measured from gate to gate, balanced configuration.

Z_{load} = Test circuit impedance as measured from drain to drain, balanced configuration.

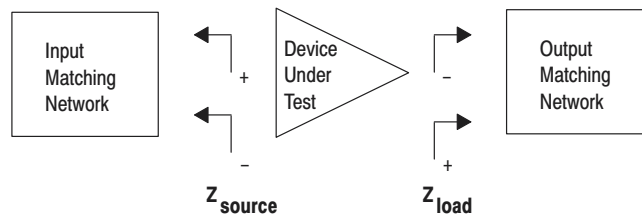
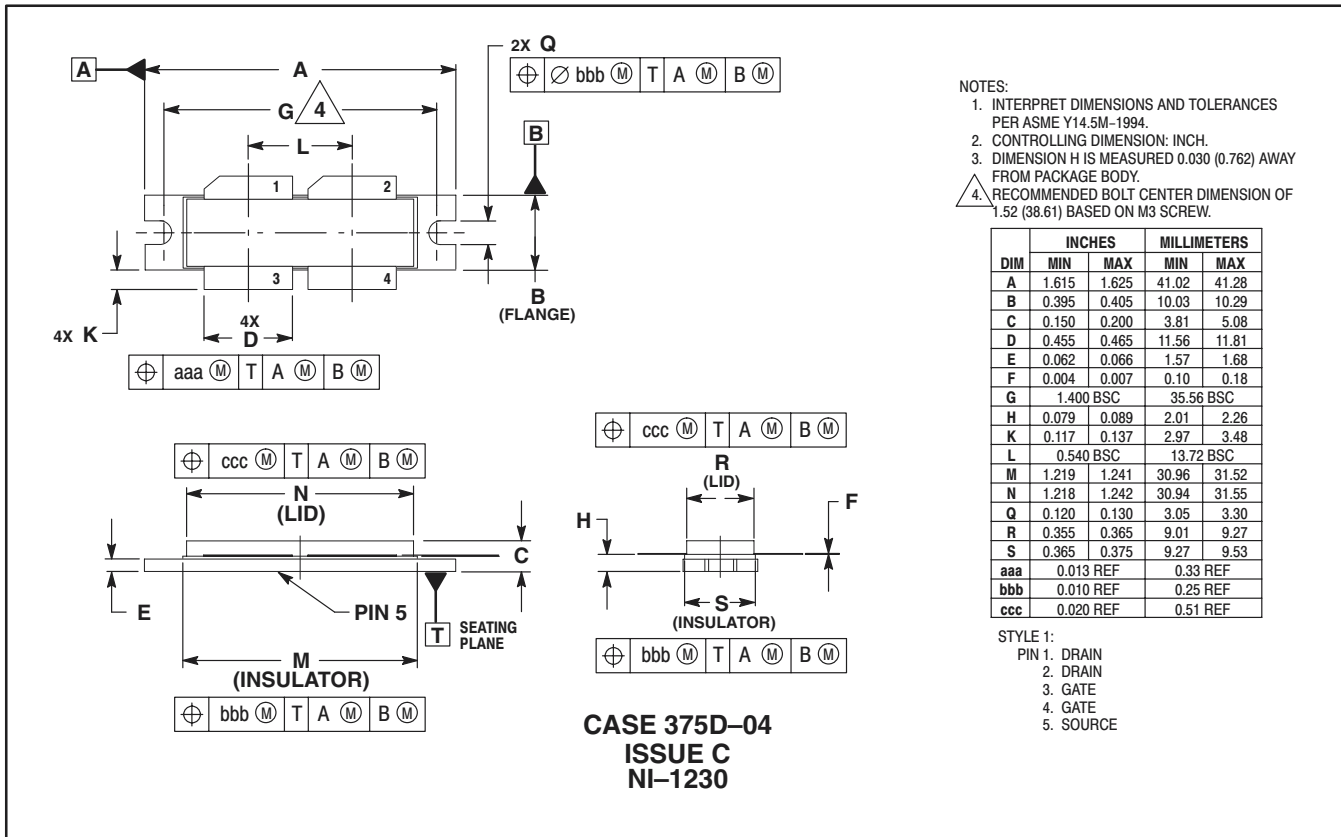


Figure 12. Series Equivalent Input and Output Impedance

PACKAGE DIMENSIONS



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